

Notice of References Cited	Application/Control No. 10/589,570	Applicant(s)/Patent Under Reexamination FAZAKAS, ANDRAS	
	Examiner Hai L. Nguyen	Art Unit 2816	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,122,724 A	06-1992	Criss, Loren O.	323/222
*	B	US-5,155,648 A	10-1992	Gauthier, Claude	361/58
*	C	US-5,559,656 A	09-1996	Chokhawala, Rahul S.	361/18
*	D	US-5,930,130 A	07-1999	Katyl et al.	363/53
*	E	US-6,178,104 B1	01-2001	Choi, Nak-Choon	363/89
*	F	US-6,628,532 B1	09-2003	Rinne et al.	363/21.06
*	G	US-6,646,842 B2	11-2003	Pan et al.	361/58
*	H	US-6,703,889 B2	03-2004	Dodson, III, George Bertran	327/434
*	I	US-6,831,447 B1	12-2004	Wittenberg, John W.	323/222
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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